

IGBT³ Chip

FEATURES:

- 600V Trench & Field Stop technology
- low V_{CE(sat)}
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

- power module
- discrete components

Applications:

- drives
- white goods
- resonant applications



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC06T60GS	600V	10A	2.44 x 2.42 mm ²	sawn on foil	Q67050- A4333-A101

MECHANICAL PARAMETER:

Raster size	2.44 x 2.42				
Emitter pad size	1.558 x 1.577	mm ²			
Gate pad size	0.361 x 0.513				
Area total / active	5.9 / 3.6	mm ²			
Thickness	70	μm			
Wafer size	150	mm			
Flat position	270	deg			
Max. possible chips per wafer	2485 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm AlSiCu				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
Die bond	electrically conductive glue or solder				
Wire bond	AI, <500μm				
Reject ink dot size	Ø 0.65mm ; max 1.2mm				
Recommended storage environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	600	V
DC collector current, limited by T _{jmax}	I _C	1)	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	30	Α
Gate emitter voltage	V_{GE}	±20	V
Operating junction and storage temperature	$T_{\rm j},~T_{\rm stg}$	-40 +175	°C
SC data, V _{GE} = 15V, V _{CC} = 360V, Tvj = 150°C	<i>t</i> p	5	μs

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_{j} =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value			Unit
. urumotor			min.	typ.	max.	
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 2 mA	600			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =10A		1.5	2.05	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	$I_C=150\mu A$, $V_{GE}=V_{CE}$	4.1	4.9	5.7	
Zero gate voltage collector current	I _{CES}	V_{CE} =600V , V_{GE} =0V			0.6	μΑ
Gate-emitter leakage current	I_{GES}	V _{CE} =0V , V _{GE} =20V			300	nA
Integrated gate resistor	R _{Gint}			none		Ω

ELECTRICAL CHARACTERISTICS (verified by design/characterization):

Parameter	Symbol Conditions	Value			Unit	
r arameter	Symbol	Conditions	min.	typ.	max.	John
Input capacitance	Ciss	V _{CE} =25V,		551		pF
Output capacitance	Coss	$V_{GE}=0V$,		40		
Reverse transfer capacitance	Crss	f=1MHz		17		

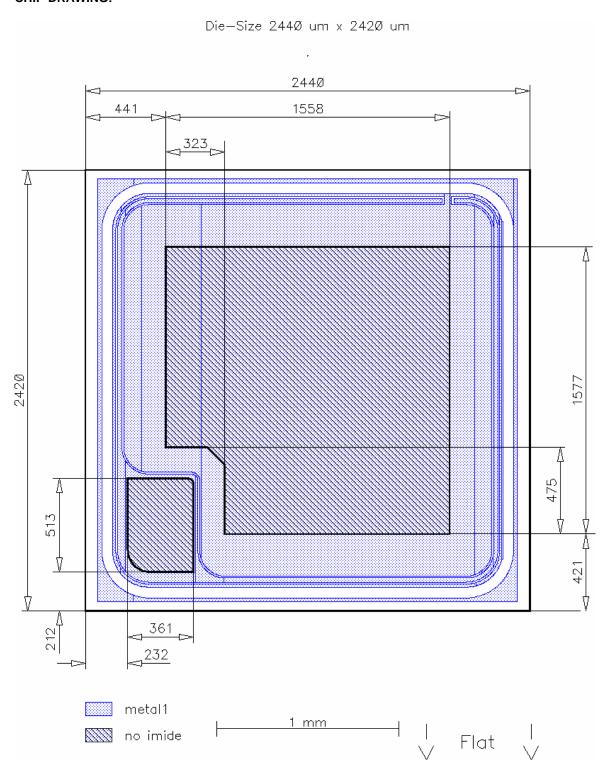
SWITCHING CHARACTERISTICS (verified by design/characterization), inductive load

Parameter	Symbol	Conditions	Value 2)			Unit
raiametei	Symbol		min.	typ.	max.	Joint
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =175°C		10		ns
Rise time	t _r	$V_{\rm CC} = 400 \rm V$		11		
Turn-off delay time	t _{d(off)}	I _C =10A, V _{GE} =-15/15V,		233		
Fall time	t_{f}	$R_{\rm G}$ = 23 Ω		63		

²⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

Electrostatic Discharge Sensitive Device according to MIL-STD 883

This chip data sheet refers to the device data sheet	IKP10N60T					
DESCRIPTION:						
AQL 0,65 for visual inspection according to failure catalog						

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Test-Normen Villach/Prüffeld

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